Search Notes

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Applicant(s)/Patent under Reexamination

10/750,926

LEE, CHANG MUK
Art Unit

Examiner

**Charles Shedrick** 

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SEARCHED					
Class	Subclass	Date	Examiner		
455	575.7	9/15/2005	cs		
343	700	9/15/2005	cs		
455	90	9/15/2005	cs		
343	702	9/15/2005	cs		
455	63.4	3/13/2006	cs		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

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Rafael Gutierez	9/15/2	005 CS